WE CLAIM:

A method of growing a SiC film within an MBE system having a growth chamber and effusion cells having shutters, comprising the steps of:

charging a first crucible with a quantity of Fullerenes; installing said first crucible into a first effusion cell; placing said first effusion cell into the growth chamber; coating a second crucible with a layer of SiC; charging said second crucible with a quantity of solid Si; installing said second crucible into a second effusion cell; placing said second effusion cell into the growth chamber; providing a SiC substrate; preparing said substrate; loading said substrate into the growth chamber; evacuating the growth chamber; heating said substrate;

heating said first effusion cell;

heating said second effusion cell; and,
growing a homoepitaxial layer of SiC upon said substrate by controllably
actuating the effusion cell shutters.

- 2. The method of claim 1 wherein said substrate is heated to a temperature of about 1500° C.
- 3. The method of claim 1 wherein said first effusion cell is heated to a temperature range of about 500° C to 650° C.
- 4. The method of claim 1 wherein said second effusion cell is heated to a temperature above about 1500° C.
- 5. The method of claim 1 wherein said substrate is prepared by chemical-mechanical polishing.
- A method of growing a \$iC film within an MBE system having a growth chamber and effusion cells having shutters, comprising the steps of:

charging a first crucible with a quantity of Fullerenes; installing said first crucible into a first effusion cell; placing said first effusion cell into the growth chamber;

coating a second crucible with a layer of SiC; charging said second crucible with a quantity of solid Si; installing said second crucible into a second effusion cell; placing said second effusion cell into the growth chamber; providing a SiC substrate; polishing said substrate; cleaning said substrate; etching said substrate; rinsing said substrate; drying said substrate; loading said substrate into the growth chamber; evacuating the growth chamber; heating said substrate to a temperature of about 1500°C; heating said first effusion cell to a temperature range of about 500° to 650° C; heating said second effusion cell to a temperature above about 1500° C; and, growing a homoepitaxial layer of SiC upon said substrate by controllably actuating the effusion cell shutters.